

## EAST Search History

| Ref # | Hits | Search Query   | DBs      | Default Operator | Plurals | Time Stamp       |
|-------|------|--|----------|------------------|---------|------------------|
| L3    | 2    | ((analyzing or analyz\$3 or measuring) near4 (fail\$4 or defect\$3) same (wafer or chip) and (postion or location) same (defect\$3 or fail \$4) and (calculat \$4 or comput \$4) same (data or feature or defect\$3) and (group or categor\$3) and (compar\$3 or model) same defect\$3).CLM. | US-PGPUB | OR               | ON      | 2008/04/23 18:10 |

4/23/08 6:10:59 PM

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